

Substitute for form 1449/PTO  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use as many sheets as necessary)				<b>Complete If Known</b>	
				Application Number	10/722,834
				Filing Date	November 26, 2003
				First Named Inventor	Lee, Dar-Shyang
				Art Unit	2441
Examiner Name	Nicholas R. Taylor				
Attorney Docket Number	015358-008700US				
Sheet	1	of	14		

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Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number Kind Code <sup>2</sup> (if known)			
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Examiner Signature	/Nicholas Taylor/			Date Considered	11/19/2009

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<sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> Applicant is to place a check mark here if English language Translation is attached.

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ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /NT/

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		Country Code <sup>3</sup>	Number <sup>4</sup>	Kind Code <sup>5</sup> (# known)				
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	FF	JP	08-125737	A	05-17-1996	Matsushita Electric Ind. Co. Ltd.		Abstract Only <input type="checkbox"/>
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